

Notice of References Cited	Application/Control No. 10/589,922		Applicant(s)/Patent Under Reexamination VAN DALEN ET AL.	
	Examiner Christopher Crutchfield		Art Unit 2466	Page 1 of 1

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	K	US-			
	L	US-			
	M	US-			

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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